Subst. Form PTO-1449	Atty, Docket No.: RPS920010172031	(IRA-10-5709)	Serial No.: To be assigned
APPLICANTS INFORMATION DISCLOSURE STATEMENT			
	Applicant: Atoji et al		
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Examiner:	ma	b P. Francis Date Considered: 7/6/06		

^{*}EXAMINER: Initial if reference considered, whether or not chation is in conformation with MPEP 609; draw line through citation if in conformance and not considered.

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RPS9200101720S1 (IRA-10-5709)

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